

# STARPOWER

## SEMICONDUCTOR

## IGBT

# GD900SGU120A3SN

## 1200V/900A 1 in one-package

## General Description

STARPOWER IGBT Power Module provides ultra low conduction loss as well as short circuit ruggedness. They are designed for the applications such as high power converters.

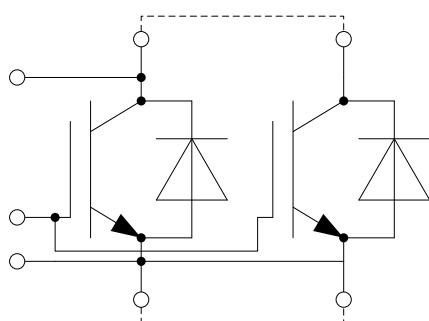
## Features

- NPT IGBT technology
- $10\mu\text{s}$  short circuit capability
- $V_{\text{CE}(\text{sat})}$  with positive temperature coefficient
- Fast & soft reverse recovery anti-parallel FWD
- Low inductance case
- AlSiC baseplate for high power cycling capability
- AlN substrate for low thermal resistance

## Typical Applications

- Inverter for motor drive
- AC and DC servo drive amplifier
- Uninterruptible power supply

## Equivalent Circuit Schematic



**Absolute Maximum Ratings**  $T_C=25^\circ\text{C}$  unless otherwise noted**IGBT**

| Symbol    | Description  | Value       | Unit |
|-----------|--|-------------|------|
| $V_{CES}$ | Collector-Emitter Voltage  | 1200        | V    |
| $V_{GES}$ | Gate-Emitter Voltage   | $\pm 20$    | V    |
| $I_C$     | Collector Current @ $T_C=25^\circ\text{C}$<br>@ $T_C=60^\circ\text{C}$ | 1130<br>900 | A    |
| $I_{CM}$  | Pulsed Collector Current $t_p=1\text{ms}$                              | 1800        | A    |
| $P_D$     | Maximum Power Dissipation @ $T_{vj}=150^\circ\text{C}$                 | 6.03        | kW   |

**Diode**

| Symbol    | Description                                    | Value | Unit |
|-----------|--|-------|------|
| $V_{RRM}$ | Repetitive Peak Reverse Voltage                | 1200  | V    |
| $I_F$     | Diode Continuous Forward Current               | 900   | A    |
| $I_{FM}$  | Diode Maximum Forward Current $t_p=1\text{ms}$ | 1800  | A    |

**Module**

| Symbol      | Description   | Value       | Unit             |
|-------------|---|-------------|------------------|
| $T_{vjmax}$ | Maximum Junction Temperature                          | 150         | $^\circ\text{C}$ |
| $T_{vop}$   | Operating Junction Temperature                        | -40 to +125 | $^\circ\text{C}$ |
| $T_{STG}$   | Storage Temperature Range                             | -40 to +125 | $^\circ\text{C}$ |
| $V_{ISO}$   | Isolation Voltage RMS, $f=50\text{Hz}, t=1\text{min}$ | 2500        | V                |

IGBT Characteristics  $T_C=25^\circ\text{C}$  unless otherwise noted

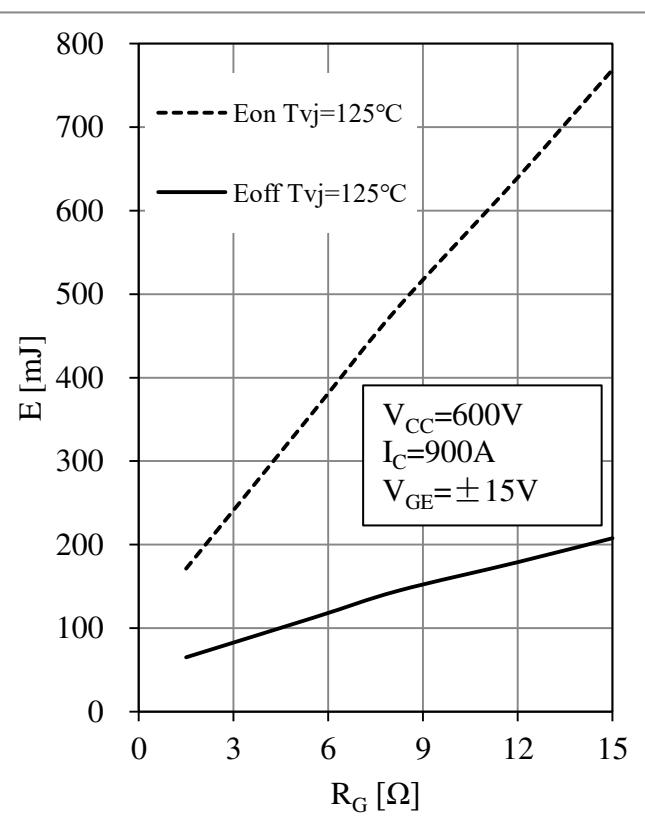
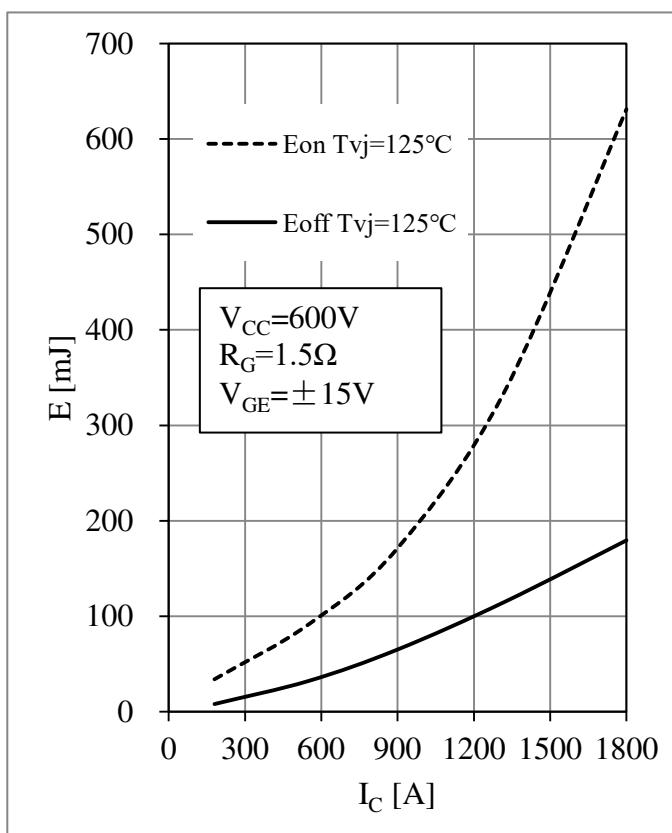
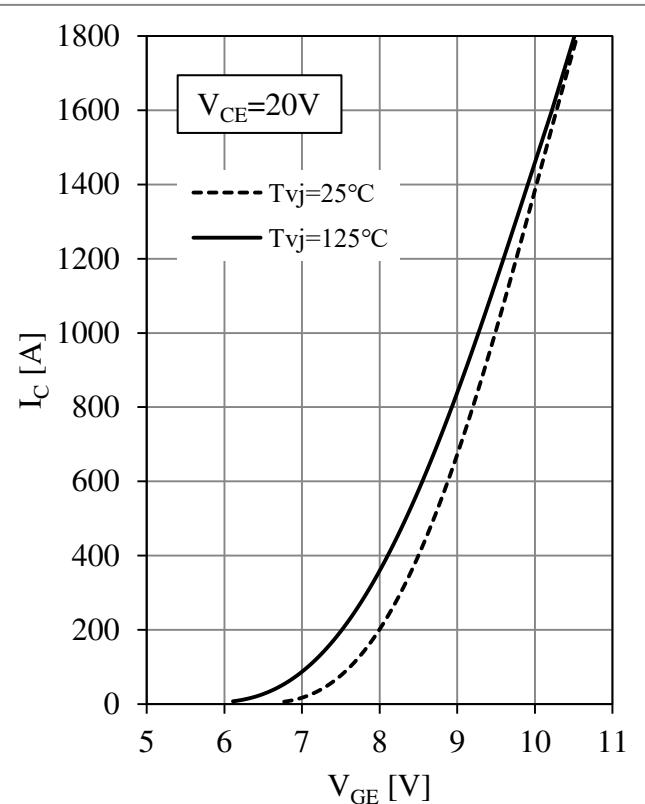
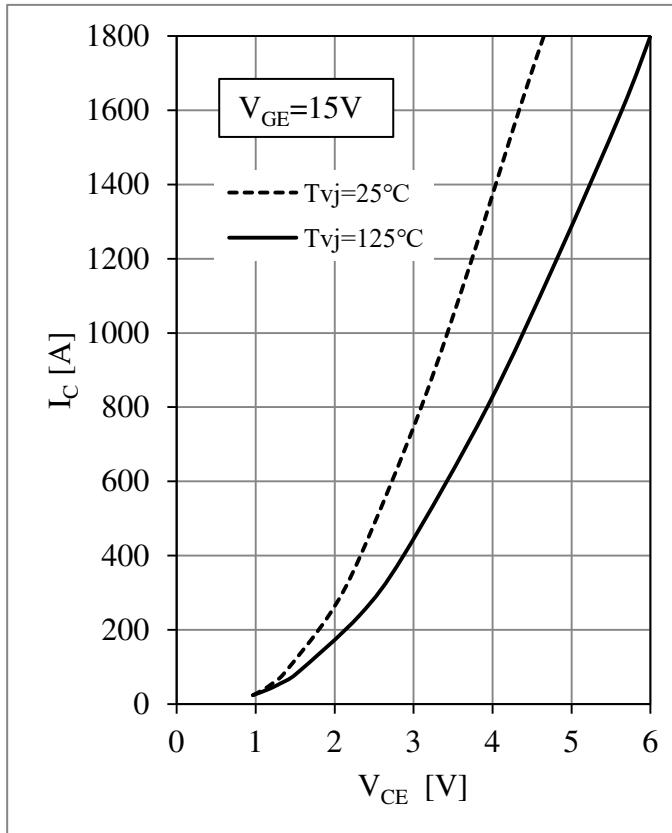
| Symbol               | Parameter                               | Test Conditions  | Min. | Typ. | Max. | Unit          |
|----------------------|---|--|------|------|------|---------------|
| $V_{CE(\text{sat})}$ | Collector to Emitter Saturation Voltage | $I_C=900\text{A}, V_{GE}=15\text{V}, T_{vj}=25^\circ\text{C}$  |      | 3.25 | 3.70 | V             |
|                      |   | $I_C=900\text{A}, V_{GE}=15\text{V}, T_{vj}=125^\circ\text{C}$   |      | 4.15 |      |               |
| $V_{GE(\text{th})}$  | Gate-Emitter Threshold Voltage          | $I_C=36.0\text{mA}, V_{CE}=V_{GE}, T_{vj}=25^\circ\text{C}$  | 4.9  | 5.9  | 6.9  | V             |
| $I_{CES}$            | Collector Cut-Off Current               | $V_{CE}=V_{CES}, V_{GE}=0\text{V}, T_{vj}=25^\circ\text{C}$  |      |      | 1.0  | mA            |
| $I_{GES}$            | Gate-Emitter Leakage Current            | $V_{GE}=V_{GES}, V_{CE}=0\text{V}, T_{vj}=25^\circ\text{C}$  |      |      | 400  | nA            |
| $R_{Gint}$           | Internal Gate Resistance                |  |      | 0.82 |      | $\Omega$      |
| $C_{ies}$            | Input Capacitance                       | $V_{CE}=25\text{V}, f=100\text{kHz}, V_{GE}=0\text{V}$   |      | 54   |      | nF            |
| $C_{res}$            | Reverse Transfer Capacitance            |  |      | 3.28 |      | nF            |
| $Q_G$                | Gate Charge                             | $V_{GE}=-15\ldots+15\text{V}$  |      | 8.65 |      | $\mu\text{C}$ |
| $t_{d(on)}$          | Turn-On Delay Time                      | $V_{CC}=600\text{V}, I_C=900\text{A}, R_G=1.5\Omega, V_{GE}=\pm 15\text{V}, L_s=40\text{nH}, T_{vj}=25^\circ\text{C}$  |      | 413  |      | ns            |
| $t_r$                | Rise Time                               |  |      | 136  |      | ns            |
| $t_{d(off)}$         | Turn-Off Delay Time                     |  |      | 593  |      | ns            |
| $t_f$                | Fall Time                               |  |      | 77   |      | ns            |
| $E_{on}$             | Turn-On Switching Loss                  |  |      | 119  |      | mJ            |
| $E_{off}$            | Turn-Off Switching Loss                 |  |      | 52   |      | mJ            |
| $t_{d(on)}$          | Turn-On Delay Time                      |  |      | 492  |      | ns            |
| $t_r$                | Rise Time                               | $V_{CC}=600\text{V}, I_C=900\text{A}, R_G=1.5\Omega, V_{GE}=\pm 15\text{V}, L_s=40\text{nH}, T_{vj}=125^\circ\text{C}$ |      | 166  |      | ns            |
| $t_{d(off)}$         | Turn-Off Delay Time                     |  |      | 723  |      | ns            |
| $t_f$                | Fall Time                               |  |      | 87   |      | ns            |
| $E_{on}$             | Turn-On Switching Loss                  |  |      | 171  |      | mJ            |
| $E_{off}$            | Turn-Off Switching Loss                 |  |      | 65   |      | mJ            |
| $I_{SC}$             | SC Data                                 | $t_p \leq 10\mu\text{s}, V_{GE}=15\text{V}, T_{vj}=125^\circ\text{C}, V_{CC}=800\text{V}, V_{CEM} \leq 1200\text{V}$   |      | 4.8  |      | kA            |

**Diode Characteristics**  $T_C=25^\circ\text{C}$  unless otherwise noted

| Symbol    | Parameter                     | Test Conditions  | Min. | Typ. | Max. | Unit          |
|-----------|-------------------------------|--|------|------|------|---------------|
| $V_F$     | Diode Forward Voltage         | $I_F=900\text{A}, V_{GE}=0\text{V}, T_{vj}=25^\circ\text{C}$   |      | 1.95 | 2.40 | V             |
|           |                               | $I_F=900\text{A}, V_{GE}=0\text{V}, T_{vj}=125^\circ\text{C}$  |      | 2.00 |      |               |
| $Q_r$     | Recovered Charge              | $V_R=600\text{V}, I_F=900\text{A}, -di/dt=5980\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$<br>$L_s=40\text{nH}, T_{vj}=25^\circ\text{C}$  |      | 67   |      | $\mu\text{C}$ |
| $I_{RM}$  | Peak Reverse Recovery Current |  |      | 420  |      | A             |
| $E_{rec}$ | Reverse Recovery Energy       |  |      | 20.7 |      | $\text{mJ}$   |
| $Q_r$     | Recovered Charge              | $V_R=600\text{V}, I_F=900\text{A}, -di/dt=5000\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$<br>$L_s=40\text{nH}, T_{vj}=125^\circ\text{C}$ |      | 136  |      | $\mu\text{C}$ |
| $I_{RM}$  | Peak Reverse Recovery Current |  |      | 423  |      | A             |
| $E_{rec}$ | Reverse Recovery Energy       |  |      | 50   |      | $\text{mJ}$   |

**Module Characteristics**  $T_C=25^\circ\text{C}$  unless otherwise noted

| Symbol      | Parameter   | Min.               | Typ.                | Max.              | Unit             |
|-------------|---|--------------------|---------------------|-------------------|------------------|
| $L_{CE}$    | Stray Inductance  |                    | 12                  |                   | nH               |
| $R_{CC+EE}$ | Module Lead Resistance, Terminal to Chip  |                    | 0.19                |                   | $\text{m}\Omega$ |
| $R_{thJC}$  | Junction-to-Case (per IGBT)<br>Junction-to-Case (per Diode)   |                    |                     | 20.72<br>43.97    | K/kW             |
| $R_{thCH}$  | Case-to-Heatsink (per IGBT)<br>Case-to-Heatsink (per Diode)<br>Case-to-Heatsink (per Module)              |                    | 8.83<br>18.7<br>6.0 |                   | K/kW             |
| M           | Terminal Connection Torque, Screw M4<br>Terminal Connection Torque, Screw M8<br>Mounting Torque, Screw M6 | 1.8<br>8.0<br>4.25 |                     | 2.1<br>10<br>5.75 | N.m              |
| G           | Weight of Module  |                    | 1050                |                   | g                |

Fig 3. IGBT Switching Loss vs.  $I_C$ Fig 4. IGBT Switching Loss vs.  $R_G$

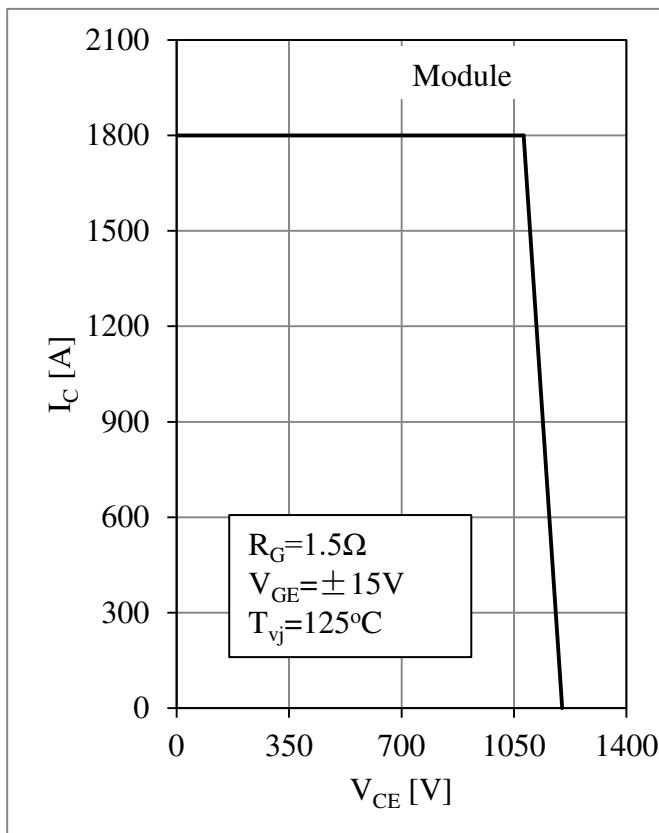


Fig 5. RBSOA

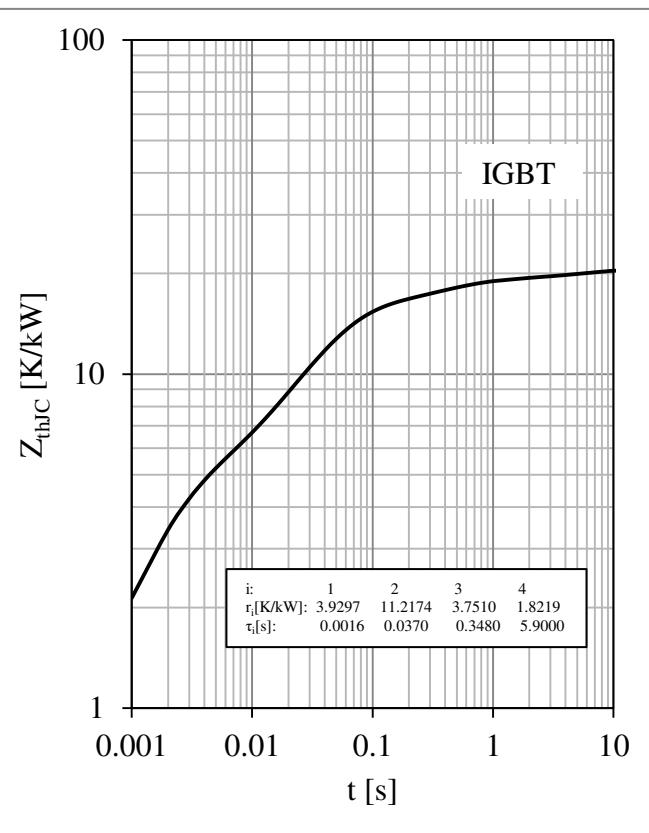


Fig 6. IGBT Transient Thermal Impedance

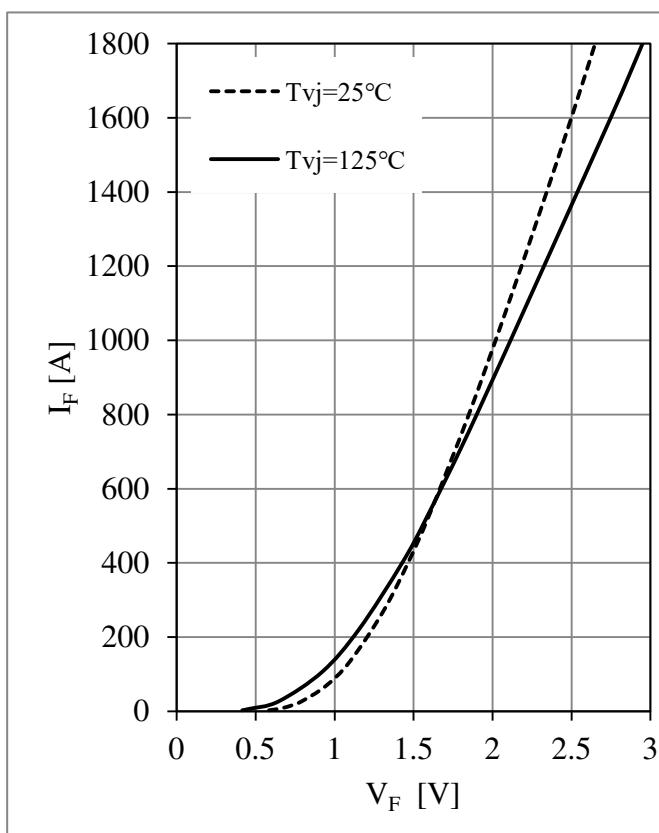


Fig 7. Diode Forward Characteristics

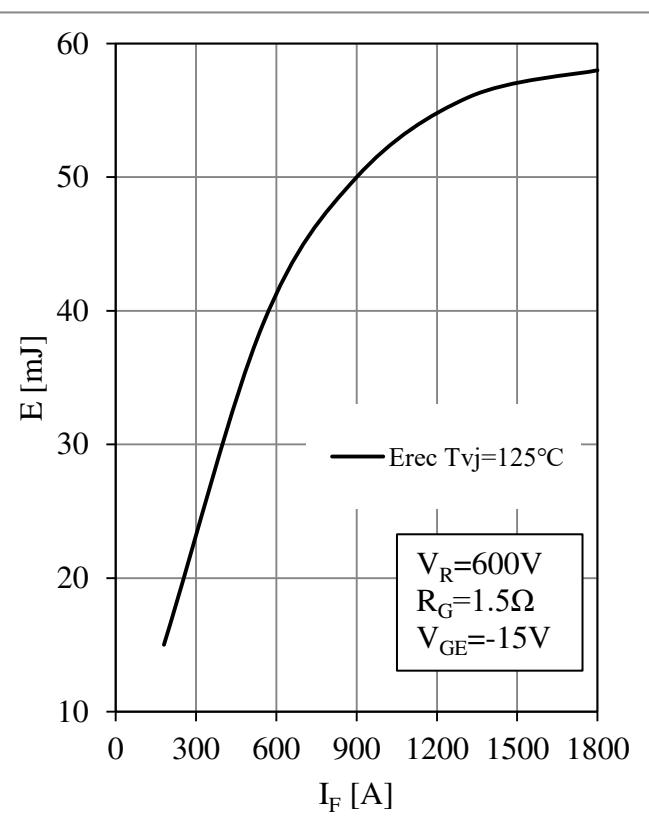


Fig 8. Diode Switching Loss vs. I\_F

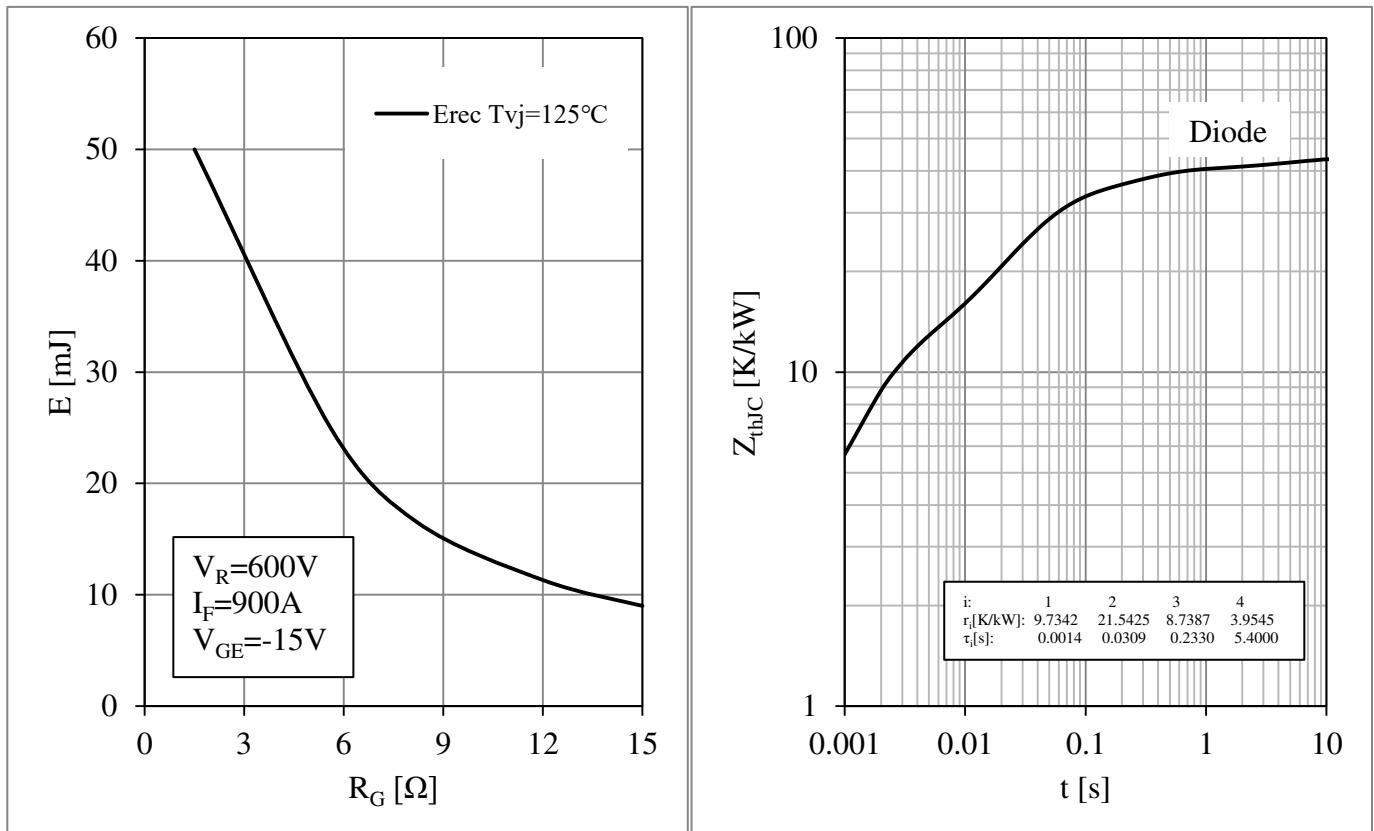
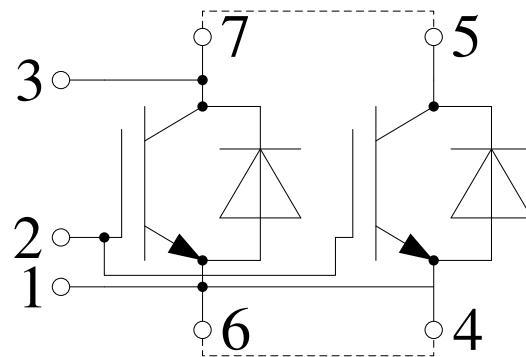
Fig 9. Diode Switching Loss vs.  $R_G$ 

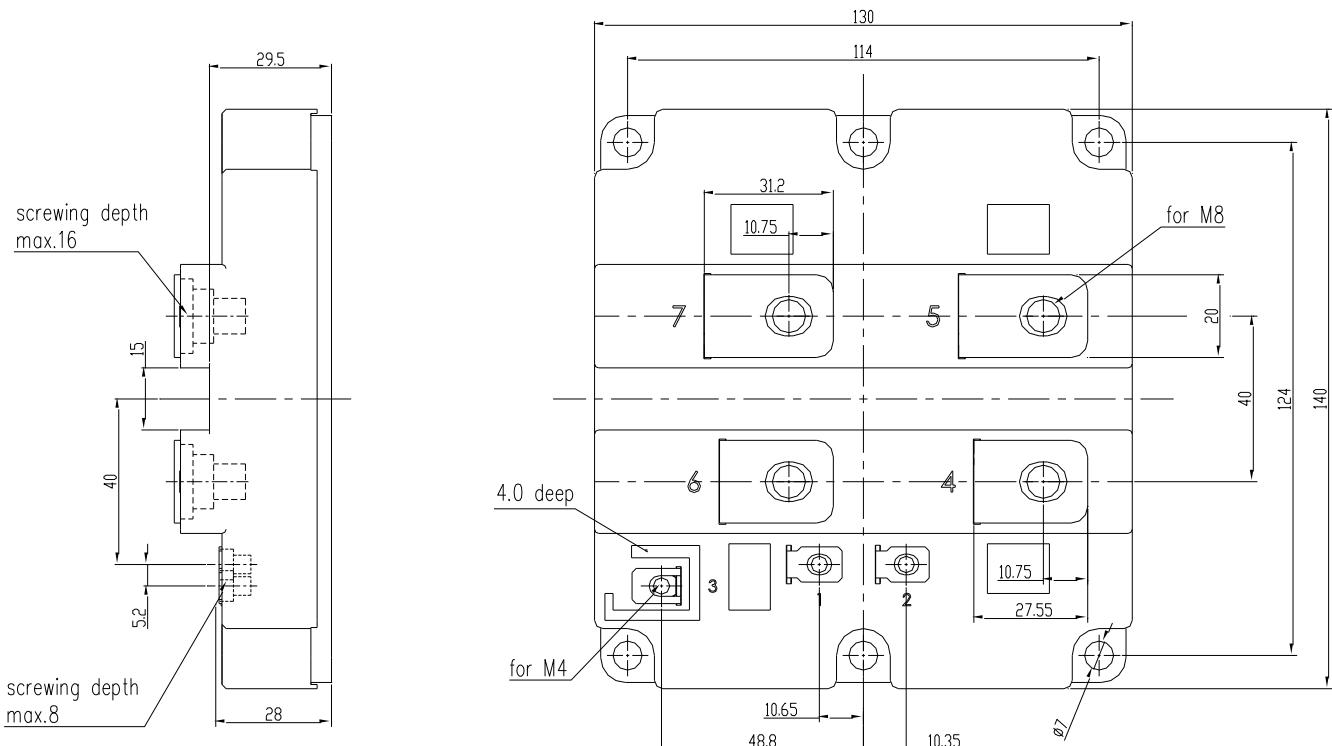
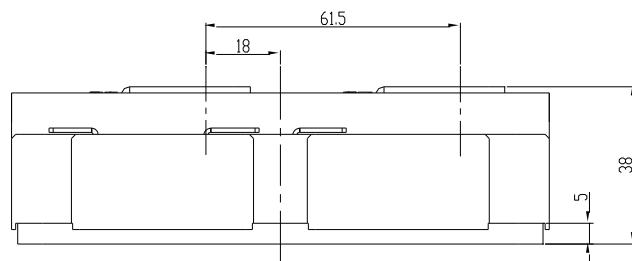
Fig 10. Diode Transient Thermal Impedance

## Circuit Schematic



## Package Dimensions

Dimensions in Millimeters



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